Self-Assembly of Bicomponent Molecular Monolayers: Adsorption Height Changes and Their Consequences

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Codeposition of two molecular species [copper phtalocyanine (CuPc, donor) and perfluoropentacene (PFP, acceptor) on noble metal (111) surfaces leads to the self-assembly of an ordered mixed layer with a maximized donor-acceptor contact area. The main driving force behind this arrangement is assumed to be the intermolecular C-H···F hydrogen-bond interactions. Such interactions would be maximized for a coplanar molecular arrangement. However, precise measurement of molecule-substrate distances in the molecular mixture reveals significantly larger adsorption heights for PFP than for CuPc. Most surprisingly, instead of leveling to increase hydrogen-bond interactions, the height difference is enhanced in the blends as compared to the heights found in single-component CuPc and PFP layers. The increased height of PFP in mixed layers points to an overall reduced interaction with the underlying substrate, and its influence on electronic properties like the interface dipole is investigated through work function measurements.

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Charge carrier injection in organic optoelectronic devices depends on the electronic properties of metal-organic interfaces, which are, therefore, of utmost importance for device efficiency. Such properties are strongly affected by the detailed interfacial structure defined by the molecular orientation with respect to the substrate, the lateral distribution, and the molecule-substrate distance. The latter, in particular, plays a central role in the interfacial energy level alignment. It affects strong chemical interactions and their associated electronic changes [1], band gap renormalization through image potential effects [2], as well as a number of other processes determining potential changes at nonchemisorptive interfaces. These are described, for example, in the electronic interface model put forward by Vázquez and co-workers [2–4], which includes the effects of permanent molecular dipoles, the “pillow effect,” and interfacial charge transfer. All of them sum up to render the so-called interface dipole, and, in particular, the two latter strongly depend on the molecule-substrate distance [2–4]. The most precise technique to determine this distance experimentally is normal incidence x-ray standing waves (XSW) [5–7], by means of which the interfaces of a number of semiconducting molecules with various surfaces have been studied [1,8–16].

Going beyond single-component layers, here we report on the use of XSW to determine the molecule-substrate distances in donor-acceptor molecular blends, which are not only highly relevant for many organic devices but also have interfacial properties often differing from those of the corresponding single-component layers [17–19]. We provide a complete structural characterization of a stoichiometric 1:1 monolayer blend of copper phtalocyanine (CuPc, donor) and perfluoropentacene (PFP, acceptor) on the Ag(111) and Cu(111) substrates. The lateral order of the 2D blends and the molecule-substrate distances have been characterized using scanning tunneling microscopy (STM) and XSW, respectively. The former evidences highly crystalline mixed monolayers, while the latter reveals how the molecules in the blends significantly change their molecule-substrate distances with respect to those in single-component layers. Finally, we analyze the impact of those changes on the interface electronic properties by means of photoemission work function measurements.

Constant current STM images show that depositing PFP, CuPc, or molecular blends on Ag(111) and Cu(111) leads to the self-assembly of ordered molecular layers in which molecules adopt a flat-lying configuration. The structure of PFP or CuPc monolayers on Ag(111) and Cu(111) have already been reported in the literature [12,20–24]. We, therefore, place our focus on the mixed layers. When codeposited (or deposited sequentially one after the other, which renders the same results) in an approximately 1:1 ratio, the two molecules form an ordered structure similar to that found for closely related systems [17,25,26], in which molecules of one type surround themselves by the other type maximizing donor-acceptor contact and C-H···F intermolecular hydrogen bonds (Fig. 1). The experimental unit cell parameters are summarized in
Table I. These, in combination with the discrete azimuthal domain orientations measured, allow us to put forth rectangular commensurate structures as tentative epitaxial models (see Table I).

Normal incidence x-ray standing wave measurements of the donor-acceptor mixtures have been performed at the beamline ID32 of the ESRF probing the C, N, and F atoms and are summarized in Fig. 2. Because of the molecular compositions, the photoelectron signal of the N and F atoms can be unambiguously ascribed to CuPc and PFP, respectively. However, a more complex scenario is found for C, which is contained in both molecules. We disentangle the signal from each molecule in the mixture’s XSW photoemission spectra based on previous high-resolution XPS studies [Fig. 2(a)] performed at the beamline ALOISA of the synchrotron Elettra [17]. Three separate peaks are resolved [Fig. 2(a)]. From highest to lowest binding energies, these correspond to PFP’s C_F component (carbon atoms bound to fluorine), PFP’s C_C component (carbon atoms bound solely to carbon) convolved with CuPc’s C_N component (carbon atoms bound to nitrogen), and CuPc’s remaining components, C_C and C_H (carbon atoms bound solely to carbon or also hydrogen). In our XSW analysis, we only consider C_F in PFP and C_{C/H} in CuPc, which can each be fitted by a single peak and are expected to give the most accurate results; the second peak in which the components of both molecules overlap is disregarded.

Figure 2(b) shows examples of a reflectivity curve (red) and of the photoelectron yield curves (green) for CuPc’s C_{C/H} and N, as well as PFP’s C_F and F obtained for each experiment.

<table>
<thead>
<tr>
<th>Experiment</th>
<th>Model</th>
<th>Experiment</th>
<th>Model</th>
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<tbody>
<tr>
<td>Ag(111)</td>
<td>Cu(111)</td>
<td></td>
<td></td>
</tr>
<tr>
<td>a</td>
<td>22 ± 2 Å</td>
<td>23.1 Å</td>
<td>21 ± 1 Å</td>
</tr>
<tr>
<td>b</td>
<td>29 ± 1 Å</td>
<td>30.0 Å</td>
<td>27 ± 2 Å</td>
</tr>
<tr>
<td>α</td>
<td>89° ± 6°</td>
<td>90°</td>
<td>89° ± 5°</td>
</tr>
<tr>
<td>E.M.</td>
<td>(8.0/0.6)</td>
<td>(0.5/11.0)</td>
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FIG. 2 (color online). (a) Reflectivity curve (red triangles) and C_{1s}, N_{1s}, and F_{1s} photoelectron yield curves (green curves; those of C and N are offset for clarity) for the molecular mixture on Ag(111) (CuPc = blue, PFP = yellow, mix = green). Right: Also on Ag(111), C_{1s} photoemission intensity of the mix at photon energies corresponding to the minimum (hν_1) and close to the maximum (hν_2) of the reflectivity curve. The fitted curve (red) is made up of three Gaussians, each corresponding to the different chemical environments of the carbon atoms in the molecules: PFP’s C_F component (yellow filling), CuPc’s C_H and C_C components (blue filling), and a convolution of PFP’s C_C and CuPc’s C_N (grey filling). The associated atoms are marked correspondingly in the molecular diagrams in the center.

(b) Reflectivity curve (red triangles) and C_{1s}, N_{1s}, and F_{1s} photoelectron yield curves (green curves) for the molecular mixture on Ag(111) (CuPc = blue, PFP = yellow, mix = green). Right: Also on Ag(111), C_{1s} photoemission intensity of the mix at photon energies corresponding to the minimum (hν_1) and close to the maximum (hν_2) of the reflectivity curve. The fitted curve (red) is made up of three Gaussians, each corresponding to the different chemical environments of the carbon atoms in the molecules: PFP’s C_F component (yellow filling), CuPc’s C_H and C_C components (blue filling), and a convolution of PFP’s C_C and CuPc’s C_N (grey filling). The associated atoms are marked correspondingly in the molecular diagrams in the center.

(c) Molecular adsorption heights of CuPc monolayers (left) [12,13], PFP monolayers (right) [10,11], and the PFP + CuPc mix (center) on the Ag(111) (top) and Cu(111) (bottom) surfaces, including height changes in the mixed layers referred to the single-component monolayers. Error in d_H is about 0.05 Å [27]. Distance to the substrate is not to scale.
The CF and F atoms, suggesting that the entire molecule is and mixed layers are found in the acceptor molecule PFP. Pronounced changes comparing single-component [10 on Ag(111) and Cu(111) are qualitatively similar: the most heights show consistently lower values on Cu(111) than on [12 when going from Au(111) through Ag(111) to Cu(111) decreasing height on increasingly interactive substrates CuPc, PTCDA, or DIP, all of which show a clear trend of interaction strength between the molecule and the under-

The molecule-substrate distance generally mirrors the interaction strength between the molecule and the underlying surface. This has been reported, for instance, for CuPc, PTCDA, or DIP, all of which show a clear trend of decreasing height on increasingly interactive substrates when going from Au(111) through Ag(111) to Cu(111) [12–15]. In line with those observations, all our measured heights show consistently lower values on Cu(111) than on Ag(111). However, disregarding this difference, the results on Ag(111) and Cu(111) are qualitatively similar: the most pronounced changes comparing single-component [10–13] and mixed layers are found in the acceptor molecule PFP. Our analysis reveals a substantial height change in both the C_F and F atoms, suggesting that the entire molecule is raised \( \sim 0.3 \) Å from the surface in the mixture. In contrast, neither the height of CuPc as a whole nor its configuration (with N atoms at slightly lower height than the C atoms) show substantial changes.

In single-component layers, CuPc lies closer to the substrate than PFP, both on Ag(111) and Cu(111) [10–13]. Upon blend formation, the raising up of PFP further increases the height difference between donors and acceptors [Fig. 2(c)]. This is contrary to expectations, since hydrogen bonding strength is known to increase with bond linearity and with shorter bond lengths [29,30]. The intermolecular C-H · · · F bonds assumed to drive the self-assembly would, therefore, be strongest in a coplanar arrangement and tend to level the molecular heights in the blends. Consequently, other driving forces must be behind these surprising changes. Substrate-mediated effects seem most intuitive and may arise from changes in the interface electronics related to the new supramolecular environment in the blends [17,18], which, in turn, modify the molecule-substrate interactions and the associated adsorption distances.

On the whole, the increased molecule-substrate distance of PFP and unchanged distance of CuPc suggest an overall reduced interaction of the mixed molecular layer with the underlying substrate. Reduced molecule-substrate interactions as a result of enhanced intermolecular interactions in molecular mixtures have been reported before [31,32] and show an analogy to coordination chemistry or Pauling’s rules, where increased coordination numbers (interactions with substrate and surrounding molecules vs only with the substrate) weaken the strength of each single bond [33]. However, this is the first quantitative report on the associated changes in the molecule-substrate distances of molecular blends, which are of great importance for the understanding of the interfacial electronic properties [2–4,17].

The changes in adsorption height found in the mixed layer are expected to lead to variations in the interface dipole. These variations are measurable as changes in the system’s work function and are typically obtained from the secondary electron cutoff in ultraviolet photoemission spectra (UPS) [34,35]. The work function dependence on coverage was first determined for each molecule on Ag(111) and Cu(111) by first measuring that of the clean substrate as reference and performing further measurements after each subsequent step in the evaporation. The results are shown in Fig. 3(a). As expected in nonpolar molecules [34,35], in all cases, the work function is found to change steadily up to certain “saturation” coverage associated with a completely covered surface [monolayer (ML) coverage], after which it remains practically constant. The work function shift for 1 ML on Ag(111) and Cu(111) was found to be \(-0.41\) and \(-0.33\) eV for PFP and \(-0.44\) and \(-0.72\) eV for CuPc. Previously reported values, available to the best of our knowledge only for the PFP-based interfaces, are in good agreement with our results [10,11].

We now turn our attention to the work function of the mixed layers. Figure 3(b) shows the vacuum level shifts associated with the deposition of the CuPc + PFP molecular mixture and of just PFP. The same quantity of PFP (namely, approximately the one needed to form the stoichiometric 1:1 molecular blend) is found to shift the vacuum level by different amounts when deposited on the submonolayer CuPc/metal (rendering a mixed layer) and on the clean metal [36]. On Cu(111), 0.42 ML of PFP was deposited onto 0.48 ML CuPc/Cu(111) producing a shift of \( \Delta \Phi_{\text{mix}}(\text{Cu}) = -0.10 \) eV in the work function. From the known coverage dependence of the work function of the PFP/Cu(111) system, we find that \( \Delta \Phi_{\text{mix}}(\text{Cu}) \) is an \(-40\%\) reduction of the expected value for a direct 0.42 ML PFP deposition on Cu(111) \( \Delta \Phi_{\text{pure}}(\text{Cu}) = -0.17 \) eV. The scenario on Ag (111) is very similar: 0.32 ML of PFP deposited onto
We may, thus, assume that only the PFP dipole changes suggest that the CuPc dipole does not vary upon mixing.

The change in the effective PFP dipole may be obtained from the experimentally determined work function changes \( \Delta \Phi_{\text{pure}} \) and \( \Delta \Phi_{\text{mix}} \) by using the Helmholtz equation

\[
\Delta \Phi = \frac{ePn}{\epsilon_0},
\]

where \( P \) is the effective dipole moment per molecule, \( n \) is the areal density of dipoles [37], \( e \) is the elementary charge, \( \epsilon \) is the relative dielectric constant \((\epsilon \sim 1)\), and \( \epsilon_0 \) is the vacuum permittivity. We estimate that upon mixing, the effective dipole moment associated with PFP changes from \( P_{\text{pure}} = 1.75 \) D to \( P_{\text{mix}} = 1.10 \) D on Ag(111) and from \( P_{\text{pure}} = 1.52 \) D to \( P_{\text{mix}} = 0.90 \) D on Cu(111).

The most important effects that contribute to the interface dipole are (i) the Pauli repulsion between the molecule’s orbitals and the metal’s electrons decaying into vacuum, (ii) charge transfer between molecule and substrate, and (iii) the molecules’ intrinsic electric dipole moment [38]. We discard option (ii) as a possible explanation for the observed changes, since charge transfer values calculated on Ag(111) [39] indicate that this effect results in a net dipole change in the opposite direction. Option (iii) is, likewise, ruled out as a main contributor to the reduction in \( P \), since changes in the intrinsic dipolar moment in the mix due to modified molecular distortions lead to net dipole changes in opposite directions on Ag(111) and on Cu(111) on Ag(111), when going from a single-component layer to a mixed layer, the net change in intramolecular dipole points into the surface, whereas on Cu(111), it points away from it. We argue that while all contributions are present, only the Pauli repulsion (i) can explain the common trend observed on Ag(111) and Cu(111) and must, therefore, be the effect contributing the most to the experimentally observed changes in \( P \): the increased molecule-substrate distance of PFP found in the mixture translates into a reduced Pauli repulsion, thereby decreasing the effective interface dipole.

In conclusion, we have characterized the lateral and vertical structures of CuPc and PFP molecular mixtures in a 1:1 ratio on Ag(111) and Cu(111) substrates. Contrary to what might be expected in a molecular blend stabilized by hydrogen bonding, XSW measurements revealed that CuPc and PFP lie at considerably different heights. Most strikingly, that difference is enhanced in the mixed layers as compared to the respective heights in single-component layers. While CuPc remained virtually at the same height upon mixing, PFP was found to raise up substantially (\( \sim 0.3 \) Å) on both the Ag(111) and Cu(111) substrates. Such a change in the adsorption height of PFP is expected to affect interface phenomena. Our photoemission measurements show this effect is, indeed, measurable, as we find that the work function shift caused by deposition of PFP onto CuPc/metal to form the molecular blend is smaller than the shift found for the deposition of the same amount of PFP onto the bare metal substrate. We hereby provide a direct measure of the effect of a molecule’s adsorption height on vacuum level shifts and, in turn, interfacial energy level alignment.

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[28] As each atomic species was measured at more than one spot on the sample, the reflectivity curves shown in Fig. 2 are two of several and correspond to the F11 yield curves shown in the figure.


[36] Because of the different molecular sizes, less PFP coverage than CuPc is required for a 1:1 ratio. Nominal deposition of 0.32 ML PFP on 0.48 ML CuPc gave, as obtained from a statistical analysis of 14 STM images, 72% of the surface covered with a 1:1 mixture, 2% with patches of ordered PFP, and the remaining 26% empty, in good agreement with the nominal deposition thicknesses. In turn, 0.42 ML PFP on 0.48 ML CuPc/Cu implies a minor excess of PFP with respect to a stoichiometric 1:1 mixture, rendering a small amount (~10%) of coexisting pure PFP patches.

[37] n = nd, where θ is the coverage of PFP and nd is the dipole density for full monolayer coverage, which is 1/132 Å2 for PFP/Ag(111), and 1/142 Å2 for PFP/Cu(111), as determined from STM measurements of the respective monolayers.